

Application/Control No.	Applicant(s)/Patent under Reexamination
10/693,967	CHUNG ET AL.
Examiner	Art Unit

Nicholas Augustine

2179

SEARCHED					
Class	Subclass	Date	Examiner		
715	767	12/7/2007	NA		
715	802	12/7/2007	NA		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
Inventor name search	12/7/2007	NA	
East Search: US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	12/7/2007	NA	
NPL Search: IEEE XPlore; Google; Jux2; ACM; Proquest;Datastarweb	12/7/2007	NA	
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